

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/829,248	NAKASHIMA E	ΓAL.
Examiner	Art Unit	
ALEX LIEW	2624	

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
382/103,104,107,115-118,124-127 limited to text search	8/10/2008	AL		